

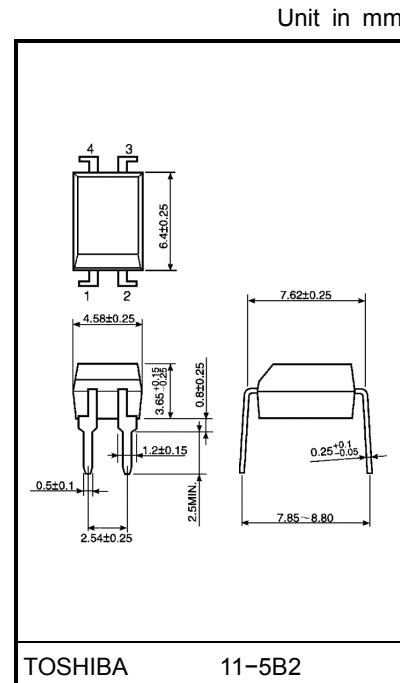
TOSHIBA Photocoupler GaAs Ired & Photo-Transistor

TLP421

Office Equipment
 Household Appliances
 Solid State Relays
 Switching Power Supplies
 Various Controllers
 Signal Transmission Between Different Voltage Circuits

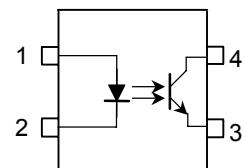
The TOSHIBA TLP421 consists of a silicone photo-transistor optically coupled to a gallium arsenide infrared emitting diode in a four lead plastic DIP (DIP4) with having high isolation voltage (AC: 5kVRMS (min)).

- Collector-emitter voltage: 80V (min.)
- Current transfer ratio: 50% (min.)
Rank GB: 100% (min.)
- Isolation voltage: 5000V_{rms} (min.)
- UL recognized: UL1577
- BSI approved: BS EN60065: 1994
 - Approved no.8411
 - BS EN60950: 1992
 - Approved no.8412
- SEMKO approved: EN60065, EN60950, EN60335
 - Approved no.9910249/01



Weight: 0.26 g

Pin Configurations (top view)



- 1 : Anode
- 2 : Cathode
- 3 : Emitter
- 4 : Collector

- Option(D4)type

TÜV approved: DIN VDE0884

Approved no.R9950202

Maximum operating insulation voltage: 890VPK

Maximu permissible overvoltage: 8000VPK

**(Note): When a VDE0884 approved type is needed,
please designate the “Option(D4)”**

Making the VDE applocation: DIN VDE0884

- Construction mechanical rating

	7.62mm Pitch Typical Type	10.16mm Pitch TLPxxxF Type
Creepage distance	7.0mm(min)	8.0mm(min)
Clearance	7.0mm(min)	8.0mm(min)
Insulation thickness	0.4mm(min)	0.4mm(min)

Current Transfer Ratio

Type	Classi- fication (*1)	Current Transfer Ratio (%) (I_C / I_F)		Marking Of Classification	
		$I_F = 5mA, V_{CE} = 5V, Ta = 25^\circ C$			
		Min	Max		
TLP421	(None)	50	600	Blank, Y, Y+, G, G+, B, B+, GB	
	Rank Y	50	150	Y, Y+	
	Rank GR	100	300	G, G+	
	Rank BL	200	600	B, B+	
	Rank GB	100	600	G, G+, B, B+, GB	

(*1): Ex. rank GB: TLP421 (GB)

(Note): Application type name for certification test, please use standard product type name, i. e.

TLP421 (GB): TLP421

Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
LED	Forward current	I _F	60	mA
	Forward current derating(Ta ≥ 39°C)	ΔI _F / °C	-0.7	mA / °C
	Pulse forward current (Note 2)	I _{FP}	1	A
	Power dissipation	P _D	100	mW
	Power dissipation derating	ΔP _D / °C	-1.0	mW / °C
	Reverse voltage	V _R	5	V
Detector	Junction temperature	T _j	125	°C
	Collector-emitter voltage	V _{C EO}	80	V
	Emitter-collector voltage	V _{E CO}	7	V
	Collector current	I _C	50	mA
	Power dissipation(single circuit)	P _C	150	mW
	Power dissipation derating (Ta ≥ 25°C)(single circuit)	ΔP _C / °C	-1.5	mW / °C
Junction temperature		T _j	125	°C
Operating temperature range		T _{opr}	-55~100	°C
Storage temperature range		T _{stg}	-55~125	°C
Lead soldering temperature (10s)		T _{sol}	260	°C
Total package power dissipation		P _T	250	mW
Total package power dissipation derating (Ta ≥ 25°C)		ΔP _T / °C	-2.5	mW / °C
Isolation voltage (Note 3)		BV _S	5000	V _{rms}

(Note 2): 100μs pulse, 100Hz frequency

(Note 3): AC, 1 min., R.H.≤ 60%. Apply voltage to LED pin and detector pin together.

Recommended Operating Conditions

Characteristic	Symbol	Min	Typ.	Max	Unit
Supply voltage	V _{CC}	—	5	24	V
Forward current	I _F	—	16	25	mA
Collector current	I _C	—	1	10	mA
Operating temperature	T _{opr}	-25	—	85	°C

Individual Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
LED	Forward voltage	V _F	I _F = 10 mA	1.0	1.2	1.3	V
	Reverse current	I _R	V _R = 5 V	—	—	10	µA
	Capacitance	C _T	V = 0, f = 1 MHz	—	30	—	pF
Detector	Collector-emitter breakdown voltage	V _{(BR) CEO}	I _C = 0.5 mA	80	—	—	V
	Emitter-collector breakdown voltage	V _{(BR) ECO}	I _E = 0.1 mA	7	—	—	V
	Collector dark current	I _D (I _{CEO})	V _{CE} = 24 V (ambient light below 1000 lx)	—	0.01 (0.1)	0.1 (10)	µA
			V _{CE} = 24 V (ambient light Ta = 85°C below 1000 lx)	—	0.6 (1)	50 (50)	µA
	Capacitance (collector to emitter)	C _{CE}	V = 0, f = 1 MHz	—	10	—	pF

Coupled Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Current transfer ratio	I _C / I _F	I _F = 5 mA, V _{CE} = 5 V	Rank GB	50	—	600	%
				100	—	600	
Saturated CTR	I _C / I _{F (sat)}	I _F = 1 mA, V _{CE} = 0.4 V	Rank GB	—	60	—	%
				30	—	—	
Collector-emitter saturation voltage	V _{CE (sat)}	I _C = 2.4 mA, I _F = 8 mA	Rank GB	—	—	0.4	V
		I _C = 0.2 mA, I _F = 1 mA		—	0.2	—	
		—		—	—	0.4	

Isolation Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min	Typ.	Max	Unit
Capacitance (input to output)	C _S	V _S = 0, f = 1 MHz	—	0.8	—	—	pF
Isolation resistance	R _S	V _S = 500 V	1×10 ¹²	10 ¹⁴	—	—	Ω
Isolation voltage	BV _S	AC, 1 minute	5000	—	—	—	V _{rms}
		AC, 1 second, in oil	—	10000	—	—	
		DC, 1 minute, in oil	—	10000	—	—	Vdc

Switching Characteristics ($T_a = 25^\circ\text{C}$)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Rise time	t_r	$V_{CC} = 10\text{ V}, I_C = 2\text{ mA}$ $R_L = 100\Omega$	—	2	—	μs
Fall time	t_f		—	3	—	
Turn-on time	t_{on}		—	3	—	
Turn-off time	t_{off}		—	3	—	
Turn-on time	t_{ON}	$R_L = 1.9\text{ k}\Omega$ $V_{CC} = 5\text{ V}, I_F = 16\text{ mA}$	—	2	—	μs
Storage time	t_s		—	25	—	
Turn-off time	t_{OFF}		—	50	—	

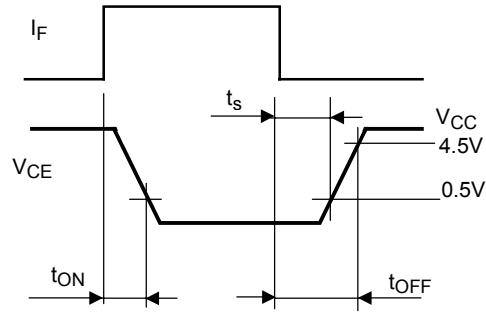
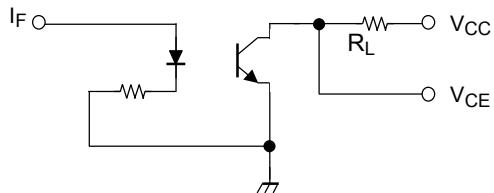
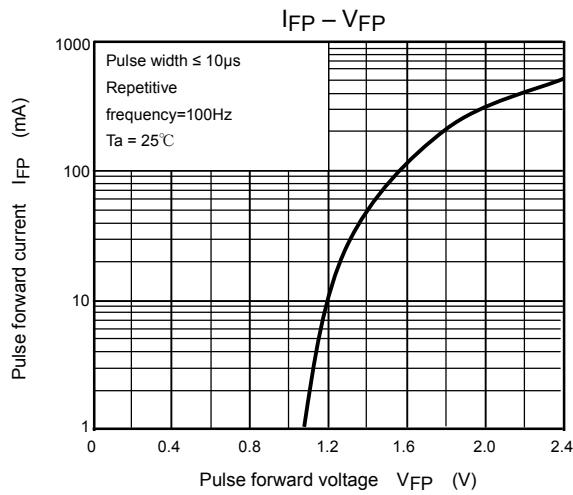
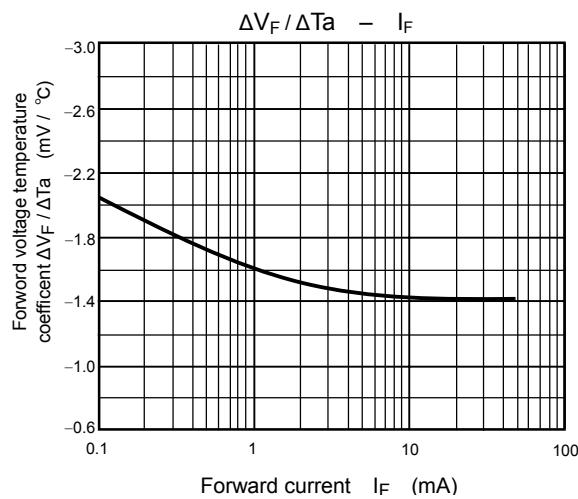
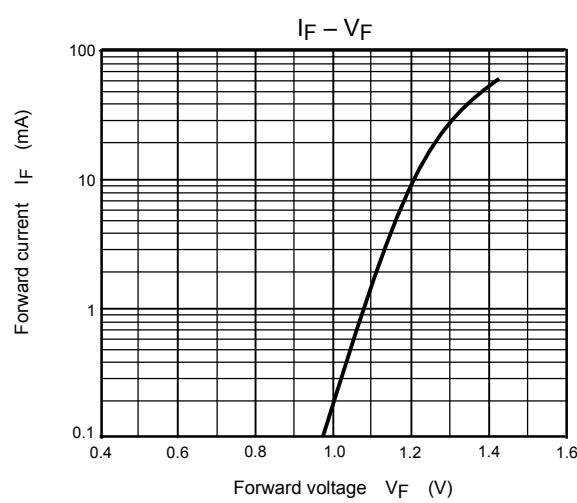
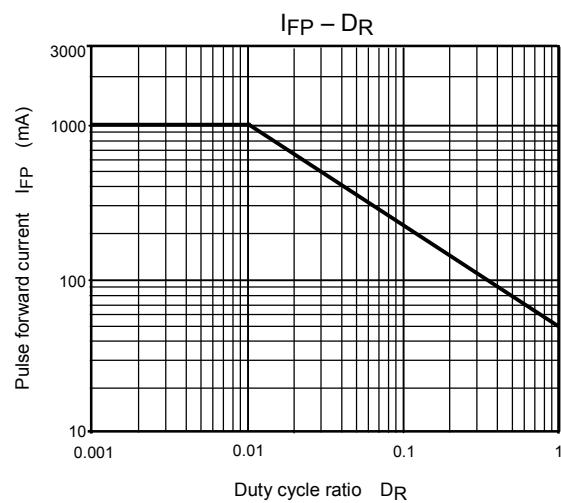
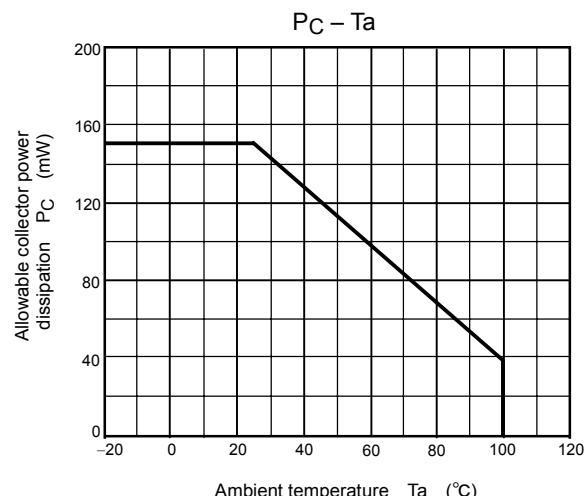
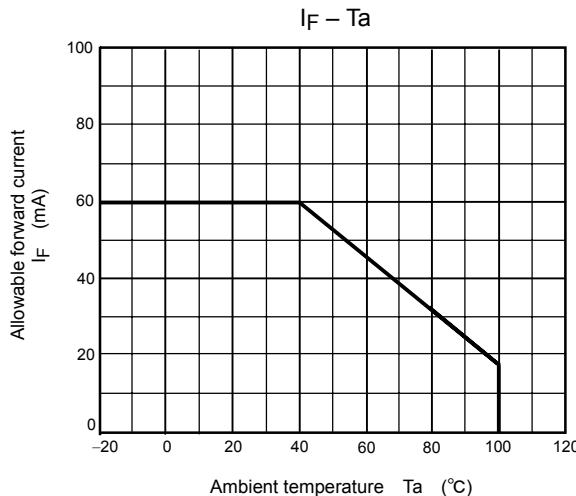
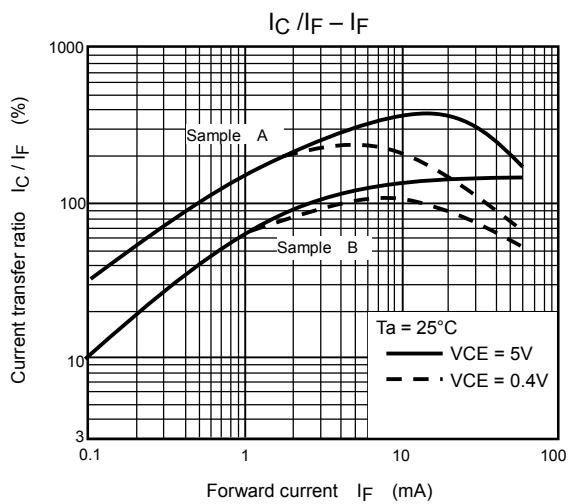
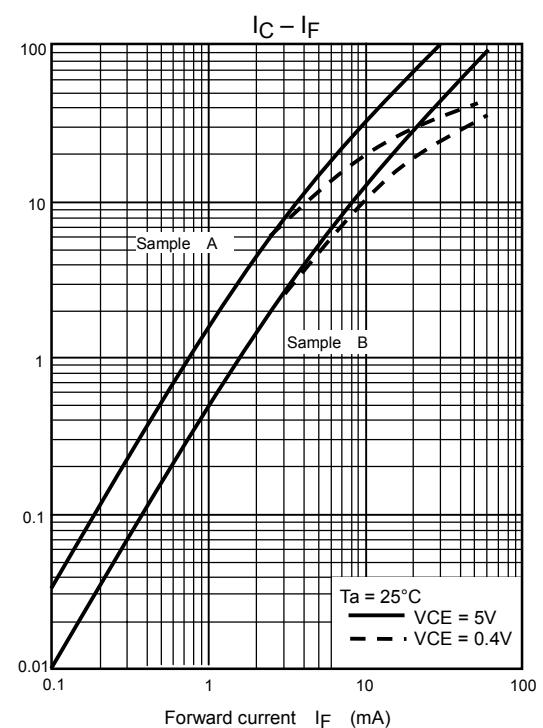
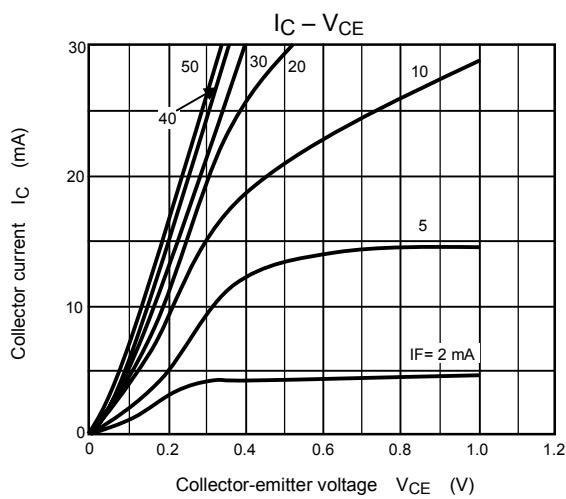
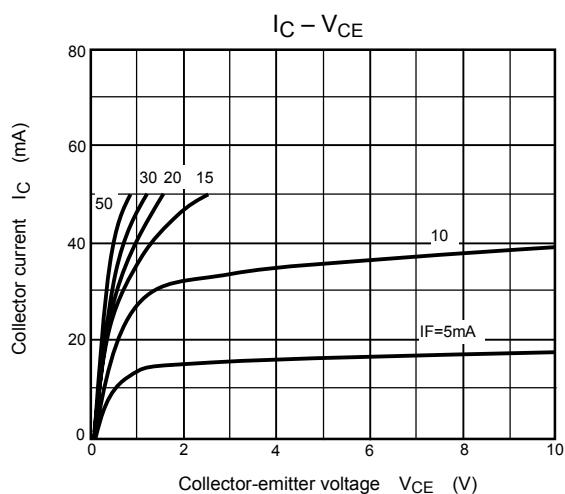
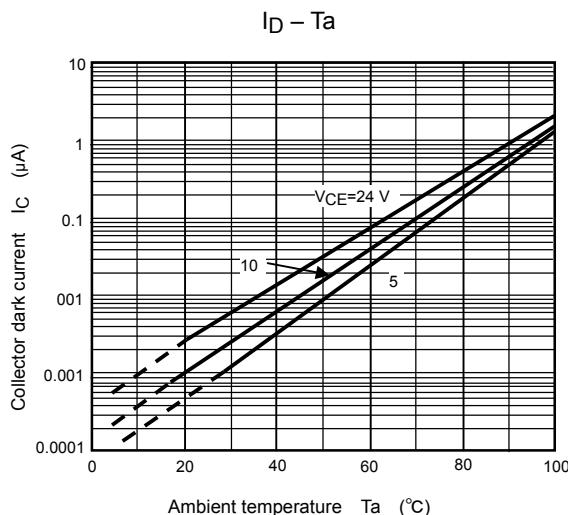
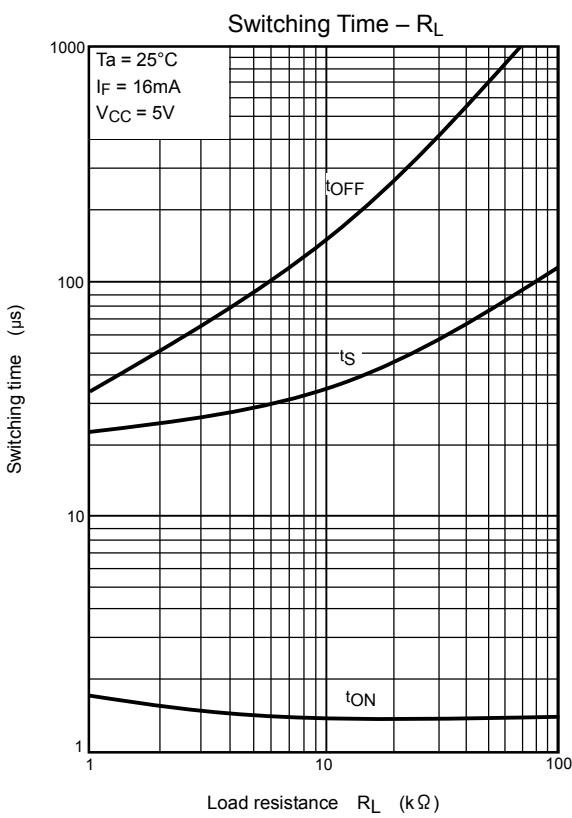
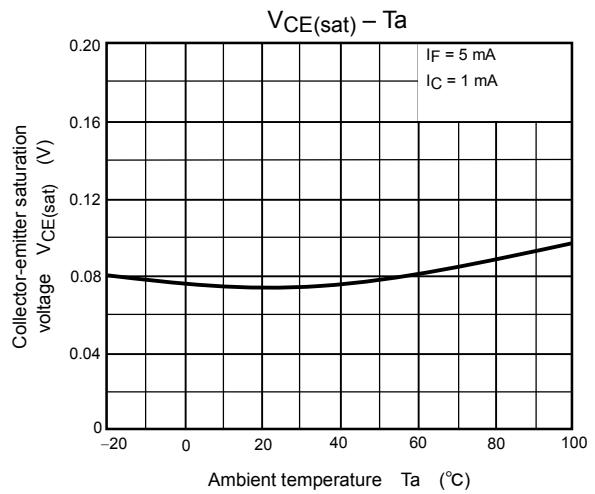
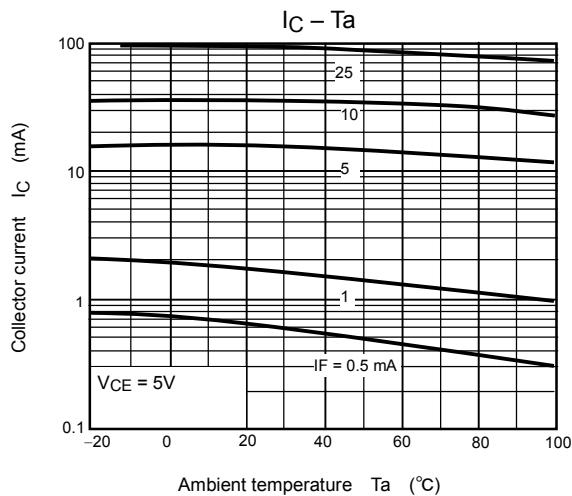


Fig.1 Switching time test circuit







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